### P-Channel Enhancement Mode Power MOSFET

## **Description**

The HM2305D uses advanced trench technology to provide excellent  $R_{\rm DS(ON)}$ , low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a load switch or in PWM applications.

#### **General Features**

•  $V_{DS} = -20V, I_{D} = -8.0A$ 

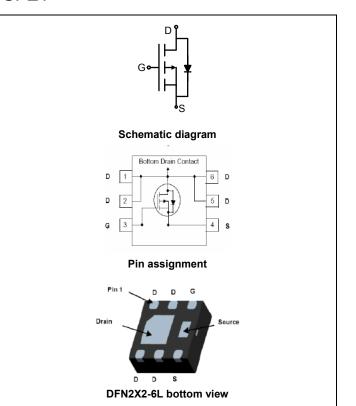
 $R_{DS(ON)}$  <75m $\Omega$  @  $V_{GS}$ =-2.5V

 $R_{DS(ON)}$  < 52m $\Omega$  @  $V_{GS}$ =-4.5V

- High power and current handing capability
- Lead free product is acquired
- Surface mount package

#### **Application**

- PWM applications
- Load switch
- Power management



### **Package Marking and Ordering Information**

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
PT 2305D	HM2305D	Á DFN2X2-6L	Ø180mm	8 mm	3000 units

#### Absolute Maximum Ratings (T<sub>A</sub>=25 ℃ unless otherwise noted)

Parameter	•	Symbol	Limit	Unit	
Drain-Source Voltage		V <sub>DS</sub>	-20	V	
Gate-Source Voltage		V <sub>GS</sub>	±12	V	
	T <sub>C</sub> =25°C		-8.0	Α	
Continuous Proin Current	T <sub>C</sub> =70°C	] ,	-6.4		
Continuous Drain Current	T <sub>A</sub> =25℃	l <sub>D</sub>	-6.0		
	T <sub>A</sub> =70°C		-4.8		
Drain Current -Pulsed (Note 1)		I <sub>DM</sub>	-32	Α	
Maximum Power Dissipation		P <sub>D</sub>	6.8	W	
Operating Junction and Storage Temper	rature Range	$T_{J}$ , $T_{STG}$	-55 To 150	$^{\circ}$	

#### **Thermal Characteristic**

Thermal Resistance, Junction-to-Ambient (Note 2)	R <sub>θJA</sub>	74	°C/W
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# Electrical Characteristics (T<sub>A</sub>=25 ℃ unless otherwise noted)

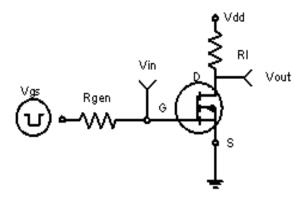
Parameter	Parameter Symbol Condition		Min	Тур	Max	Unit
Off Characteristics	·					
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V I <sub>D</sub> =-250μA	-20	-	-	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =-20V,V <sub>GS</sub> =0V	-	-	-1	μΑ
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±12V,V <sub>DS</sub> =0V	-	-	±100	nA
On Characteristics (Note 3)				•		
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>D</sub> =-250μA	-0.45	-0.7	-1.0	V
Danier Courses On Otata Basintana	Б	V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-4.1A	- 39 52			
Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =-2.5V, I <sub>D</sub> =-3A	-	58	75	mΩ
Forward Transconductance	<b>g</b> FS	V <sub>DS</sub> =-5V,I <sub>D</sub> =-2A	6	-	-	S
Dynamic Characteristics (Note4)						
Input Capacitance	C <sub>lss</sub>	\/ - 4\/\/ -0\/	-	740	-	PF
Output Capacitance	C <sub>oss</sub>	$V_{DS}$ =-4V, $V_{GS}$ =0V, F=1.0MHz	-	290	-	PF
Reverse Transfer Capacitance	C <sub>rss</sub>	F=1.UIVITZ	-	190	-	PF
Switching Characteristics (Note 4)	·					
Turn-on Delay Time	t <sub>d(on)</sub>		-	12	-	nS
Turn-on Rise Time	t <sub>r</sub>	$V_{DD}$ =-4 $V$ , $I_{D}$ =-3.3 $A$ ,	-	35	-	nS
Turn-Off Delay Time	$t_{d(off)}$	$R_L$ =-1.2 $\Omega$ , $V_{GEN}$ =-4.5 $V$ , $R_g$ =1 $\Omega$	-	30	-	nS
Turn-Off Fall Time	t <sub>f</sub>	]	-	10	ı	nS
Total Gate Charge	Qg		-	7.8	-	nC
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS}$ =-4V, $I_{D}$ =-4.1A, $V_{GS}$ =-4.5V	-	1.2	-	nC
Gate-Drain Charge	$Q_{gd}$	]	-	1.6	ı	nC
Drain-Source Diode Characteristics	•	•	•	•		•
Diode Forward Voltage (Note 3)	$V_{SD}$	V <sub>GS</sub> =0V,I <sub>S</sub> =-1.6A	-	-	-1.2	V
Diode Forward Current (Note 2)	I <sub>S</sub>		-	-	1.6	Α

#### Notes:

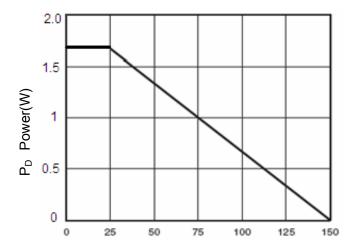
- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- **2.** Surface Mounted on FR4 Board,  $t \le 10$  sec.
- 3. Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
- 4. Guaranteed by design, not subject to production

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# **Typical Electrical and Thermal Characteristics**

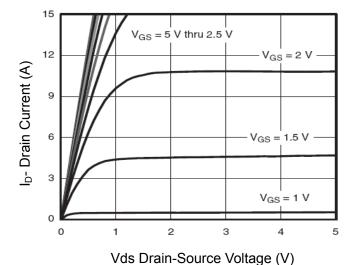


**Figure 1:Switching Test Circuit** 



T<sub>J</sub>-Junction Temperature(°C)

**Figure 3 Power Dissipation** 



**Figure 5 Output Characteristics** 

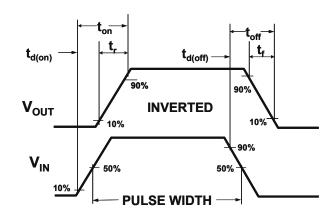
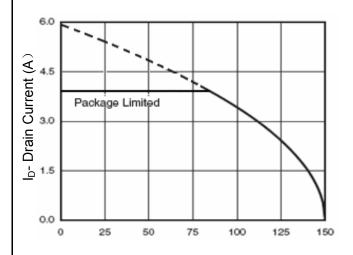
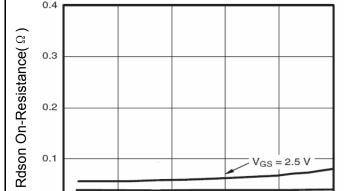


Figure 2:Switching Waveforms



T<sub>J</sub>-Junction Temperature(°C)

Figure 4 Drain Current



I<sub>D</sub>- Drain Current (A)

Figure 6 Drain-Source On-Resistance

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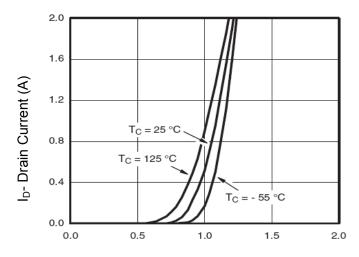
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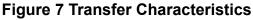
V<sub>GS</sub> = 4.5 V

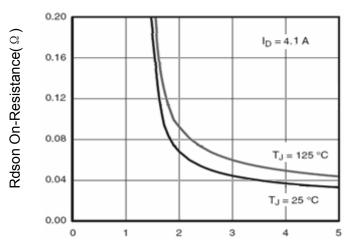
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0.0



Vgs Gate-Source Voltage (V)





Vgs Gate-Source Voltage (V)

### Figure 9 Rdson vs Vgs

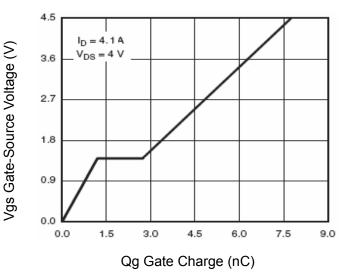
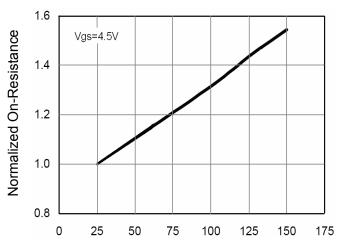
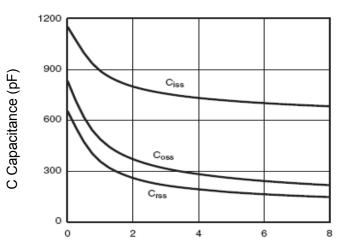


Figure 11 Gate Charge



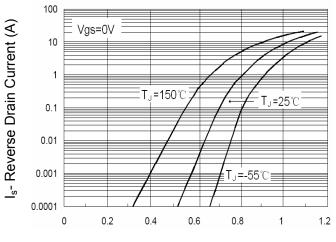
T<sub>J</sub>-Junction Temperature(°C)

# Figure 8 Drain-Source On-Resistance



Vds Drain-Source Voltage (V)

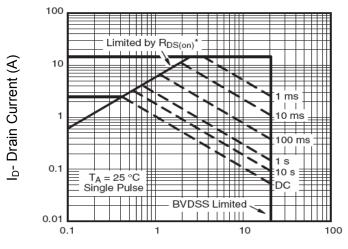
Figure 10 Capacitance vs Vds



Vsd Source-Drain Voltage (V)

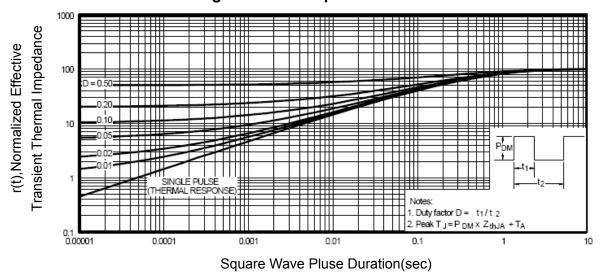
Figure 12 Source- Drain Diode Forward

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Vds Drain-Source Voltage (V)

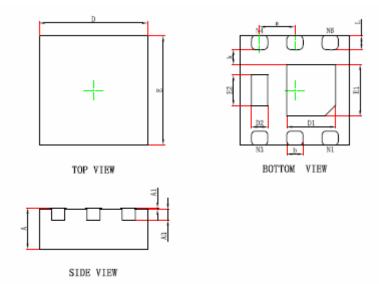
Figure 13 Safe Operation Area



**Figure 14 Normalized Maximum Transient Thermal Impedance** 

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# **DFN2X2-6L Package Information**



Symbol	Dimensions Ir	n Millimeters	Dimensions In Inches		
Symbol	Min.	Max.	Min.	Max.	
Α	0.700	0.800	0.028	0.031	
A1	0.000	0.050	0.000	0.002	
A3	0.203REF.		0.008REF.		
D	1.924	2.076	0.076	0.082	
E	1.924	2.076	0.076	0.082	
D1	0.800	1.000	0.031	0.039	
E1	0.850	1.050	0.033	0.041	
D2	0.200	0.400	0.008	0.016	
E2	0.460	0.660	0.018	0.026	
k	0.200MIN.		0.008MIN.		
b	0.250	0.350	0.010	0.014	
е	0.650TYP.		0.026TYP.		
L	0.174	0.326	0.007	0.013	

#### **Notes**

- 1. All dimensions are in millimeters.
- 2. Tolerance ±0.10mm (4 mil) unless otherwise specified
- 3. Package body sizes exclude mold flash and gate burrs. Mold flash at the non-lead sides should be less than 5 mils.
- 4. Dimension L is measured in gauge plane.
- $5. \ Controlling \ dimension \ is \ millimeter, \ converted \ inch \ dimensions \ are \ not \ necessarily \ exact.$

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